Bonding of FE-I4 Modules

J. Segal, J. Hasi, C. Kenney August 8, 2016

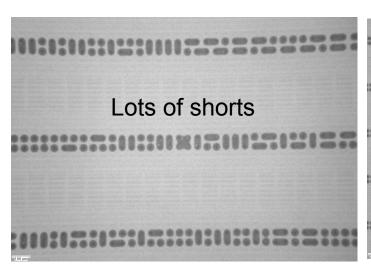




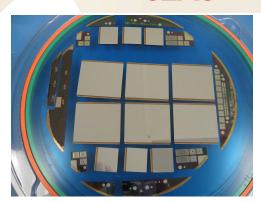
Initial Batch had Shorted Bumps

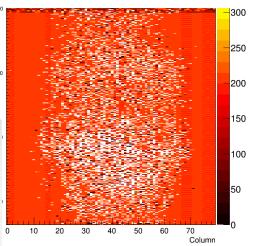
SLAC

- 6 quads (2x2) and 6 single-chip modules bumped and bonded
- Electrical testing revealed systemic problems
- X-ray imaging showed many merged bumps
- Process parameters on the edge of working
- Bumps were larger than intended









- One additional FE-I4 wafer sent to RTI by Maurice
- Partially processed
- Bumps are smaller then initial batch: 40 -> 26 μm
- Expect bonded modules by end of August: 3 SC modules first?

